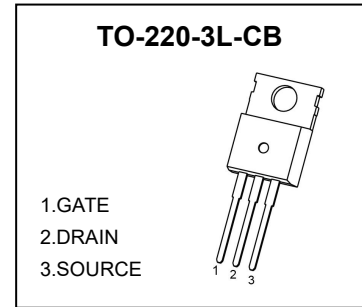


**TO-220-3L-CB Plastic-Encapsulate MOSFET**

**CJP035SN20MK** N-Channel Power MOSFET

**Key Performance Parameters**

<b>V<sub>BR(DSS)</sub></b>	<b>R<sub>DS(on)TYP</sub></b>	<b>I<sub>D</sub></b>
<b>200V</b>	<b>28.5mΩ@10V</b>	<b>48A</b>



**DESCRIPTION**

The N-Channel enhancement mode power field effect transistors is using SGT technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

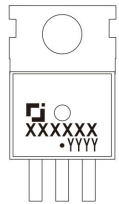
**FEATURES**

- 100% Avalanche tested
- Low drain-source on-resistance
- Low gate charge
- High current capability

**APPLICATIONS**

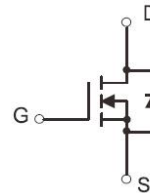
- DC/DC
- Switching application

**MARKING**



XXXXXX = 035SN20MK  
 Solid dot = Green molding compound device.  
 YYYY = Code.

**EQUIVALENT CIRCUIT**



**ABSOLUTE MAXIMUM RATINGS ( T<sub>J</sub>=25°C unless otherwise specified )**

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DS</sub>	200	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Continuous Drain Current	I <sub>D</sub>	T <sub>C</sub> =25°C	48
		T <sub>C</sub> =100°C	30
Pulsed Drain Current	I <sub>DM</sub> <sup>①②</sup>	192	A
Continuous Drain Current	I <sub>D</sub>	T <sub>A</sub> =25°C	4.7
		T <sub>A</sub> =75°C	3.5
Avalanche Current	I <sub>AS</sub> <sup>③</sup>	22	A
Single Pulsed Avalanche Energy	E <sub>AS</sub> <sup>③</sup>	121	mJ
Power Dissipation	P <sub>D</sub> <sup>①</sup>	208	W
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55~+150	°C

**Thermal Characteristics**

Parameter	Symbol	Value		Unit
		Typ	Max	
Thermal Resistance from Junction to Case	R <sub>θJC</sub>	0.4	0.6	°C/W
Thermal Resistance from Junction to Ambient	R <sub>θJA</sub> <sup>⑥</sup>	45	67.5	°C/W

# Typical Characteristics

## ELECTRICAL CHARACTERISTICS ( $T_J=25^{\circ}\text{C}$ unless otherwise specified)

### Static Characteristics

Parameter	Symbol	Test Condition	Value			Unit	
			Min	Typ	Max		
Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=250\mu A$	200	-	-	V	
Zero gate voltage drain current	$I_{DSS}$	$V_{DS}=200V, V_{GS}=0V$	$T_J=25^{\circ}\text{C}$	-	-	1.0	$\mu A$
			$T_J=125^{\circ}\text{C}$	-	-	100	
Gate-body leakage current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	$\pm 100$	nA	
Gate-threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	2.0	3.2	4.0	V	
Static drain-source on-state resistance	$R_{DS(on)}^{(4)}$	$V_{GS}=10V, I_D=20A$	$T_J=25^{\circ}\text{C}$	-	28.5	35	m $\Omega$
			$T_J=125^{\circ}\text{C}$	-	60	74	
Forward transconductance	$g_{FS}$	$V_{DS}=5V, I_D=20A$	-	42	-	S	

### Dynamic Characteristics<sup>(5)</sup>

Input capacitance	$C_{iss}$	$V_{GS}=0V, V_{DS}=100V,$ $f=1\text{MHz}$	-	1508	-	$\mu F$
Output capacitance	$C_{oss}$		-	139	-	
Reverse transfer capacitance	$C_{rss}$		-	8	-	
Gate resistance	$R_g$	$f=1\text{MHz}$	-	4.2	-	$\Omega$
Total gate charge	$Q_g$	$V_{GS}=10V, V_{DS}=100V, I_D=20A$	-	18.7	-	nC
Gate charge at threshold	$Q_{G(th)}$		-	4.7	-	
Gate-source charge	$Q_{gs}$		-	6.8	-	
Gate-drain charge	$Q_{gd}$		-	2.6	-	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=100V, V_{GS}=10V,$ $I_D=20A, R_g=10\Omega$	-	17	-	ns
Turn-on rise time	$t_r$		-	18	-	
Turn-off delay time	$t_{d(off)}$		-	29	-	
Turn-off fall time	$t_f$		-	23	-	

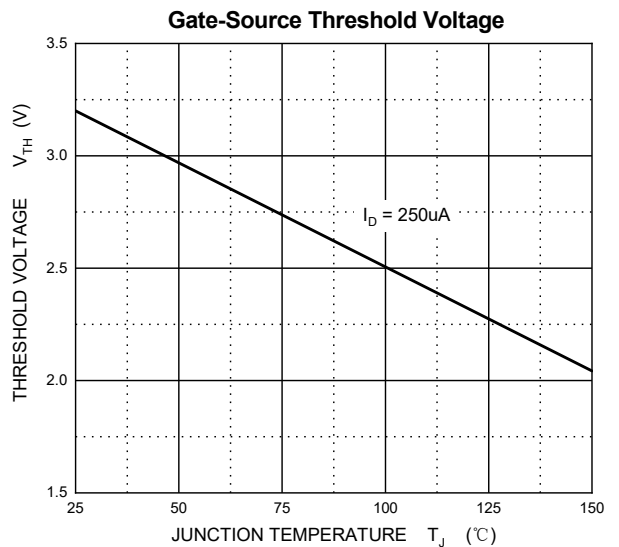
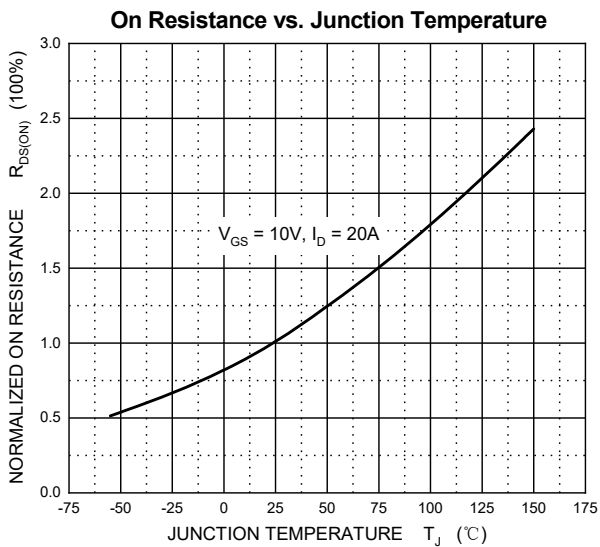
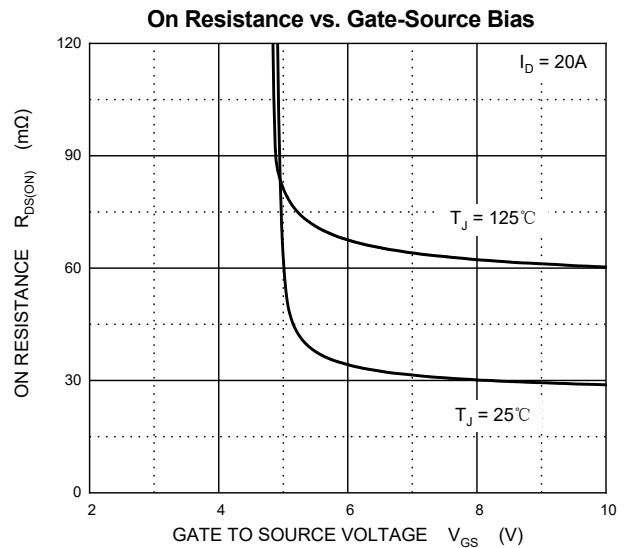
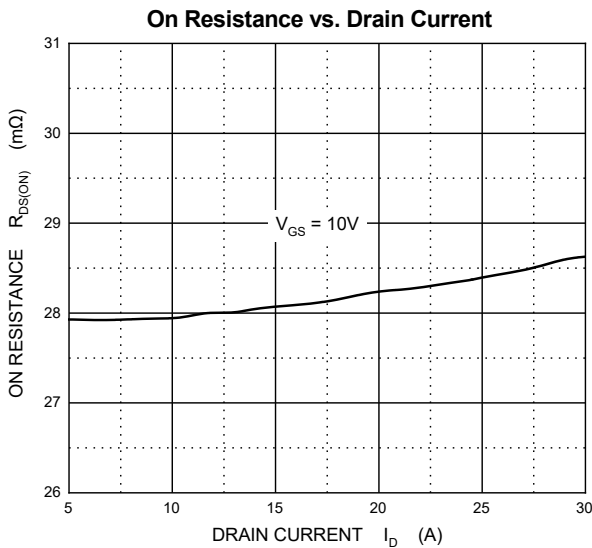
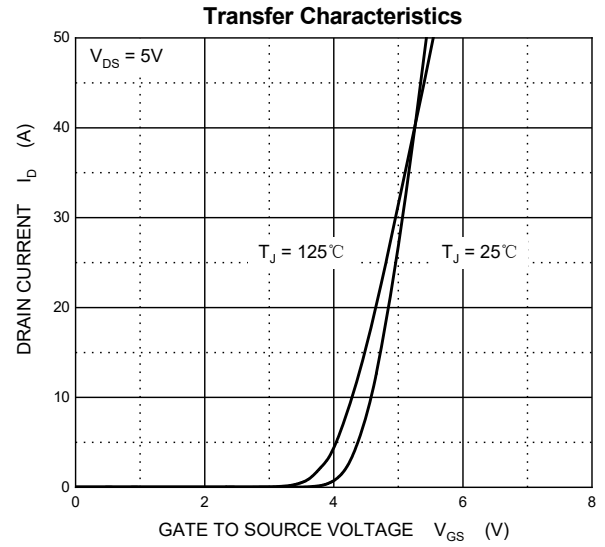
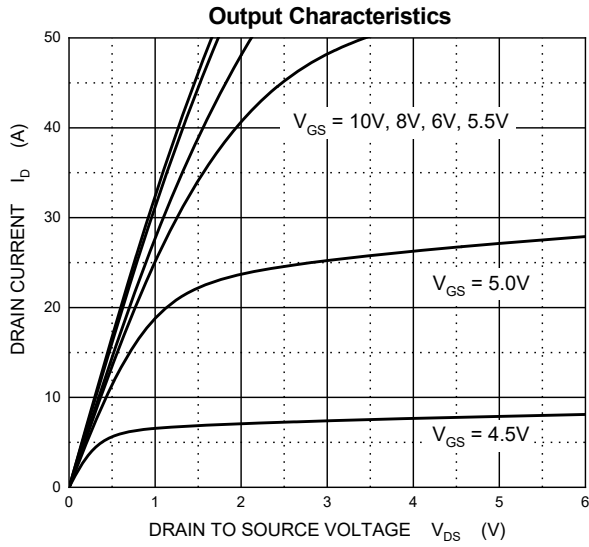
### Reverse Diode Characteristics

Drain-source diode forward voltage	$V_{SD}^{(4)}$	$V_{GS}=0V, I_S=20A$	-	-	1.2	V
Continuous drain-source diode forward current	$I_S^{(1)}$		-	-	48	A
Pulsed drain-source diode forward current	$I_{SM}^{(1)(2)}$		-	-	192	A
Reverse recovery time	$t_{rr}$	$V_{DD}=100V, I_S=20A,$	-	100	-	ns
Reverse recovery charge	$Q_{rr}$	$di/dt=100A/\mu s$	-	390	-	nC

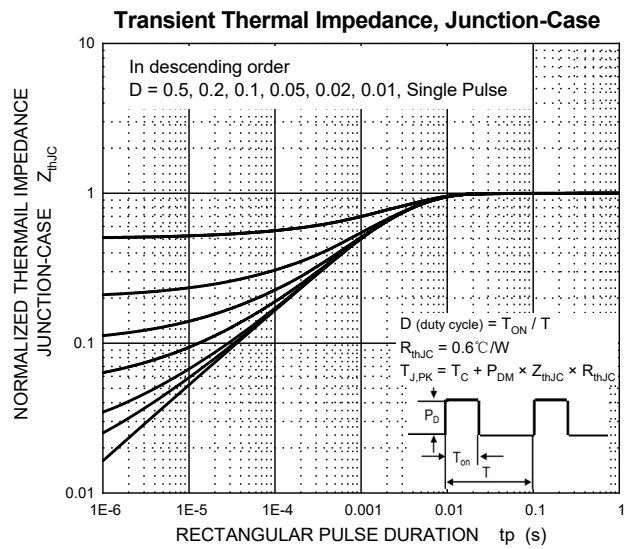
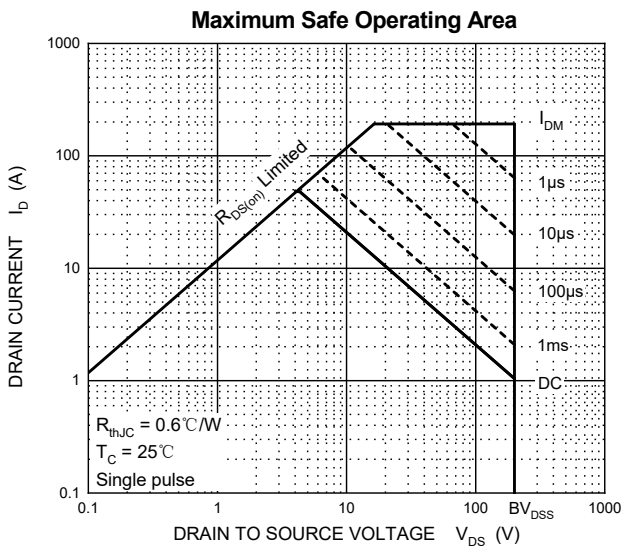
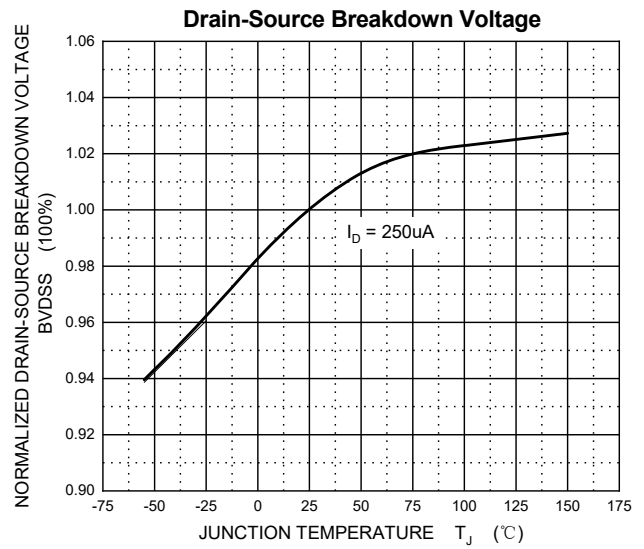
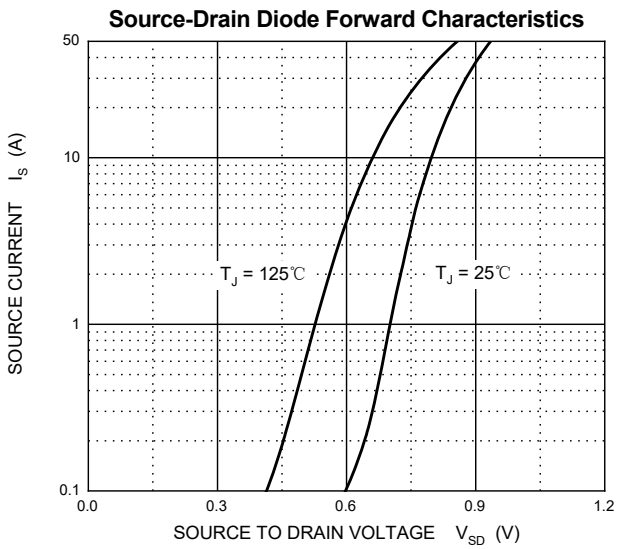
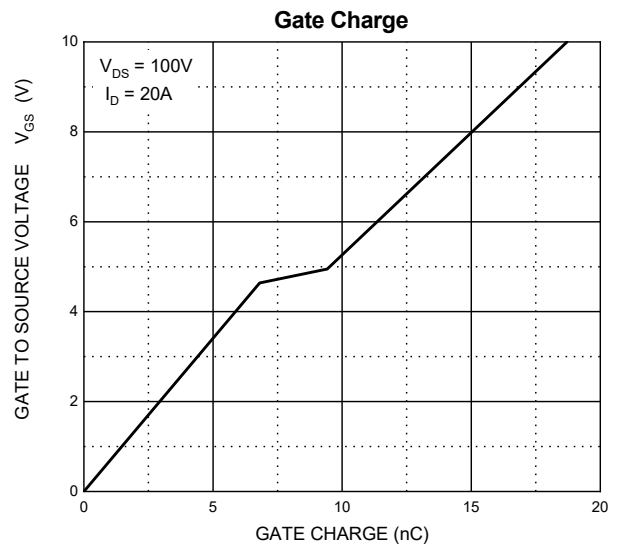
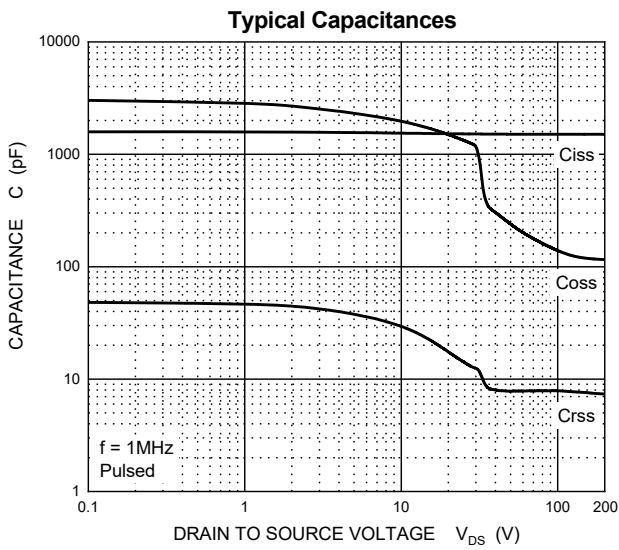
Notes:

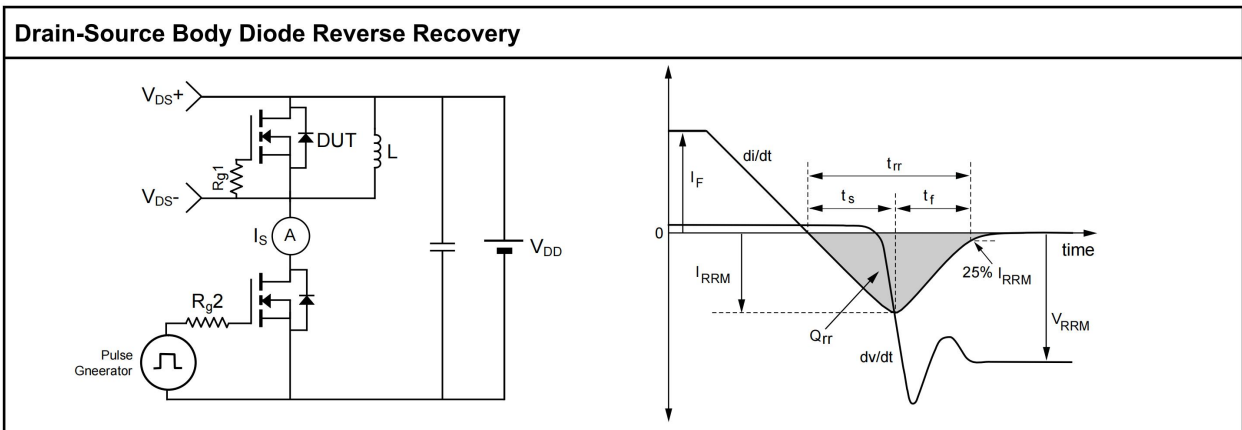
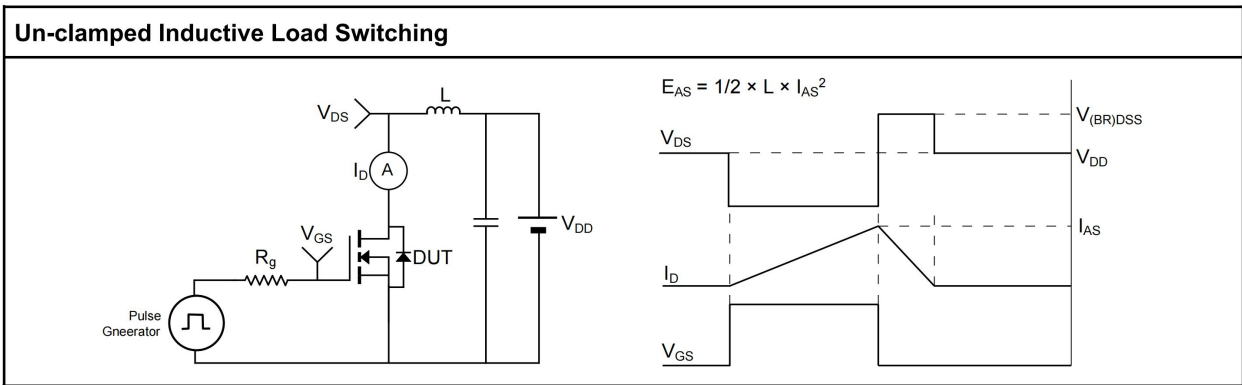
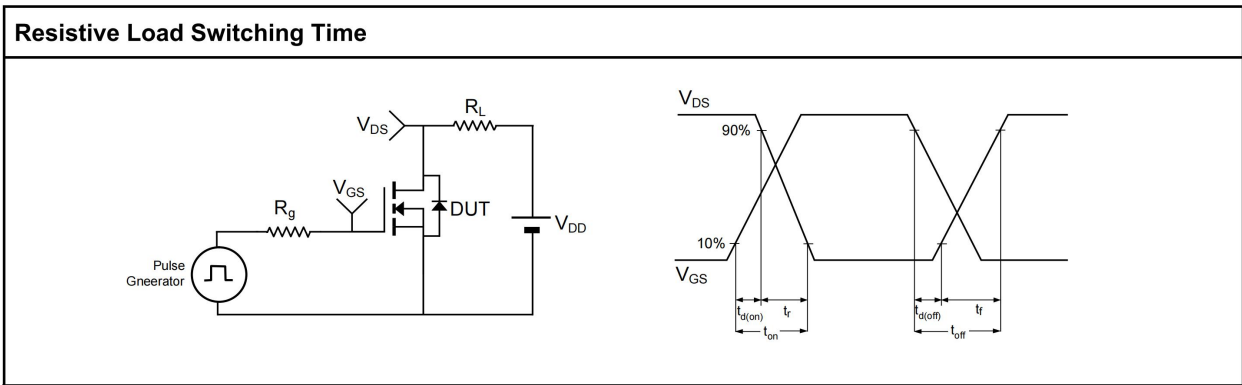
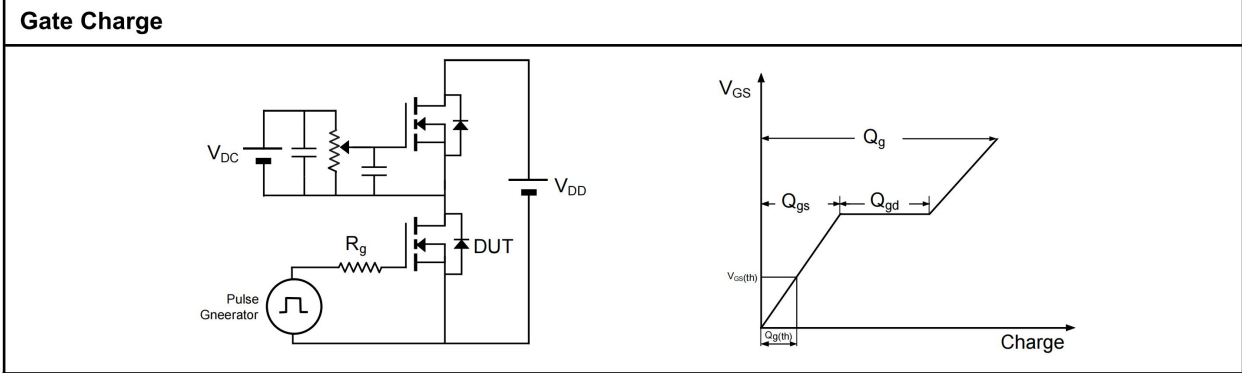
- ①.  $T_C=25^{\circ}\text{C}$  Limited only by maximum temperature allowed.
- ②.  $P_W \leq 10\mu s$ , Duty cycle  $\leq 1\%$ .
- ③. EAS condition:  $V_{DD}=100V, V_{GS}=10V, L=0.5\text{mH}, R_g=25\Omega$  Starting  $T_J=25^{\circ}\text{C}$ .
- ④. Pulse Test : Pulse Width  $\leq 380\mu s$ , duty cycle  $\leq 2\%$ .
- ⑤. Guaranteed by design, not subject to production.
- ⑥. Device mounted in a still air environment with  $T_A=25^{\circ}\text{C}$ .

# Typical Characteristics

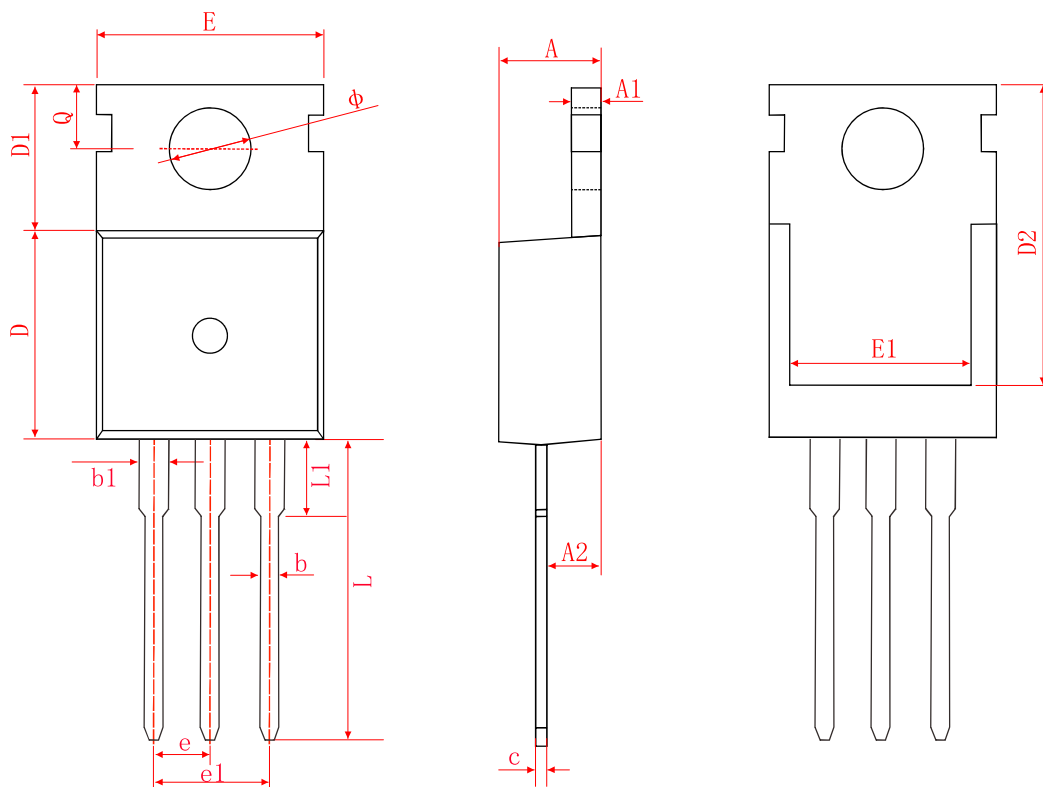


# Typical Characteristics





## TO-220-3L-CB Package Outline Dimensions



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	4.40	4.60	0.173	0.181
A1	1.25	1.35	0.049	0.053
A2	2.30	2.50	0.091	0.098
b	0.75	0.85	0.030	0.033
b1	1.25	1.42	0.049	0.056
c	0.45	0.55	0.018	0.022
D	9.10	9.30	0.358	0.366
D1	6.40	6.60	0.252	0.260
D2	13.07	13.47	0.515	0.530
e	2.54 TYP		0.100 TYP	
e1	5.08 TYP		0.200 TYP	
E	9.80	10.15	0.386	0.400
E1	7.80	8.20	0.307	0.323
Q	2.70	2.90	0.106	0.114
L	13.00	13.45	0.512	0.530
L1	-	3.40		0.134
Φ	3.50	3.70	0.138	0.146